Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | ALTENBUCHNER ET AL. | Examiner | Art Unit | Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-			
	В	US-			,
	С	US-			
	D	US-			
	Е	US-			
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	1	US-			
	J	US-			-
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q				-	
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Witkowski et al. , Biochemistry 38:11643-11650, 1999			
	٧	Seffernick et al. , J. Bacteriol. 183(8):2405-2410, 2001			
*	W	Pietzsch et al. , DECHEMA Biotechnology Conferences 4:259-262, 1990			
*	х	Bommarius et al., Chirality in Industry, Chapter 20, pages 371-397, edited by A.N. Collins, G.N. Sheldrake, and J. Crosby, 1992			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

- 2 7

Application/Control No. Applicant(s)/Patent Under Reexamination 10/088,093 ALTENBUCHNER ET AL. Notice of References Cited Art Unit Examiner Page 2 of 2 Delia M. Ramirez 1652 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G

FOREIGN PATENT DOCUMENTS

	TORLING TAKEN DOGULATO					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q				,	
	R					
	s					-
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Wiese et al. , J. Biotechnol. 80:217-230, 2000
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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